

Notice of References Cited	Application/Control No. 10/764,954		Applicant(s)/Patent Under Reexamination PAREKH, KUNAL R.	
	Examiner Tan T. Nguyen		Art Unit 2827	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,442,589	08-1995	Kowalski, Jacek	365/225.7
*	B	US-5,901,082	05-1999	Chen et al.	365/185.09
*	C	US-2004/0208071	10-2004	Mukunoki et al.	365/201
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	5-28787	02-1993	Japan		
	O	0 194 090	09-1986	Europe	Turner	
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.